

**Notice of References Cited**

Application/Control No.

09/702,755

Applicant(s)/Patent Under

Reexamination

NAKAMURA, NOBUTAKA

Examiner

Sumati Lefkowitz

Art Unit

2112

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,662,330	12-2003	Hershey, Stephen	714/748
	B	US-6,658,619	12-2003	Chen, Dayong	714/748
	C	US-6,621,796	09-2003	Miklos, Gyorgy	370/236
	D	US-6,574,668	06-2003	Gubbi et al.	709/237
	E	US-6,563,826	05-2003	Shikama, Toshihiro	370/394
	F	US-6,496,481	12-2002	Wu et al.	370/242
	G	US-6,425,105	07-2002	Piirainen et al.	714/748
	H	US-6,389,016	05-2002	Sabaa et al.	370/389
	I	US-6,335,933	01-2002	Mallory, Tracy D	370/394
	J	US-6,330,699	12-2001	Yoshioka et al.	714/746
	K	US-6,301,249	10-2001	Mansfield et al.	370/394
	L	US-6,292,470	09-2001	Uota, Toshihiro	370/252
	M	US-6,181,704	01-2001	Drottar et al.	370/410

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,091,733	07-2000	Takagi et al.	370/401
	B	US-6,069,886	05-2000	Ayerst et al.	370/336
	C	US-6,021,124	02-2000	Haartsen, Jacobus C.	370/336
	D	US-5,931,916	08-1999	Barker et al.	709/239
	E	US-5,930,233	07-1999	Kanerva et al.	370/231
	F	US-5,892,894	04-1999	Shiroshita et al.	714/4
	G	US-5,828,677	10-1998	Sayeed et al.	714/774
	H	US-5,734,659	03-1998	Mann et al.	370/474
	I	US-5,699,369	12-1997	Guha, Aloke	714/774
	J	US-5,629,948	05-1997	Hagiwara et al.	714/748
	K	US-5,477,550	12-1995	Crisler et al.	714/748
	L	US-5,313,473	05-1994	Darmon et al.	714/751
	M	US-5,136,576	08-1992	Brownlie, John D.	370/286

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,007,051	04-1991	Dolkas et al.	370/235
	B	US-4,726,027	02-1988	Nakamura et al.	714/748
	C	US-4,617,657	10-1986	Drynan et al.	370/394
	D	US-4,344,171	08-1982	Lin et al.	714/751
	E	US-4,144,522	03-1979	Kageyama et al.	714/748
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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